Search Notes			
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/619,044	MEYER ET AL.	
Examiner	Art Unit	
C. SAYALA	1761	

	SEARCHED			
Class	Subclass	Date	Examiner	
426	1	1/4/2006	cs	
43	57.1			
69	30			
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
·	DATE	EXMR
Search updated	1/4/2006	cs
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